Powder Diffraction

Ashfia Huq

Spallation Neutron Source

Oak Ridge National Laboratory





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W.H. Bragg (1862-1942) W.L. Bragg (1890-1971)





Shared 1915 Nobel Prize

·Zinc Blend (fcc not sc)
·NaCl (not molecular)
·Diamond (two overlapping fcc lattice)



Where are the atoms?

We need wavelength (λ) ~ Object size (for condensed matter that is Å)



X-ray:

- $(\lambda : 10^{-9}m 10^{-11}m)$
- λ [Å] = 12.398/E_{ph}[keV]

Source:

- Lab diffractometers
- Synchrotron Sources

Neutron:

(thermal λ : 1-4Å)

 $E_n[meV] = 81.89 / \lambda^2[Å]$

Source:

- Reactors (fission)
- Spallation Source



Crystal Structure = Basis + Lattice



Basis	_	Latuce		
***	\otimes			
System	I Angles and Dimensions	Lattices in System		
Triclinic	a≠b≠c, α≠β≠γ	P (primitive)		
Monoclinic	a≠b≠c, α=γ=90°≠β	P (primitive)		
		I (body centered)		
Orthorhombic	a≠b≠c, α=β=γ=90°	P (primitive)		
		C (base centered)		
		I (body centered)		
		F (face centered)		
Tetragonal	a=b≠c, α=β=γ=90°	P (primitive)		
		I (body centered)		
Cubic	a=b=c, α=β=γ=90°	P (primitive)		
		I (body centered)		
		F (face centered)		
Trigonal	a=b=c, 120°>α=β=γ≠90°	R (rhombohedral primitive)		
Hexagonal	a=b≠c, α=β=90°, γ=120°	R (rhombohedral primitive)		

Lattica

3d Bravais Lattices: 14 types in 7 classes



Bragg Scattering from a crystal

$$F_{hkl} = \sum_{j} f_{j} e^{2\pi i \left(hx_{j} + ky_{j} + lz_{j}\right)}$$

Simple Example:

Simple cubic cell with one atom basis at (000)

$$F_{hkl} = fe^{2\pi i(h.0+k.0+l.0)} = f$$

For bcc lattice : SC with (000, $\frac{1}{2}$ $\frac{1}{2}$ $\frac{1}{2}$) basis

$$f_{hkl} = f[e^{2\pi i(h.0+k.0+l.0)} + e^{2\pi i(h+k+l).\frac{1}{2}}] = 2f \text{ for even (h+k+l)}$$

= 0 for odd (h+k+l)

Simple Example:

Rewrite Bragg's Law for cubic system:

 $\sin^2\theta = (\lambda/4a)^2(h^2+k^2+l^2)....(1)$





In a powder diffraction measurement (Al powder), we measure Bragg angles θ using Cu K_a radiation. The Bragg angles are 19.48°,22.64°, 33.00°,39.68°, 41.83°, 50.35°, 57.05°, 59.42°. Determine the type of lattice and the lattice parameter.

θ	sin²θ	sin²θ/sin²θ _i	3*sin²θ/sin² θ _i
19.48	0.111	1	3
22.64	0.148	1.333	4
33.00	0.297	2.676	8
39.68	0.408	3.675	11
41.83	0.445	4.009	12
50.35	0.593	5.340	16
57.05	0.704	6.342	19
59.42	0.741	6.676	20

We have indexed the cell to a fcc lattice. λ = 1.5417. Plug in any of these values to eqn (1) to find a = 4.004Å.



Things get a little more complex when you consider systems that are not orthogonal

General Formula:

$$\frac{1}{d_{hkl}^2} = |H_{hkl}|^2 = (h\vec{b}_1 + k\vec{b}_2 + l\vec{b}_3).(h\vec{b}_1 + k\vec{b}_2 + l\vec{b}_3)$$

recall (reciprocal lattice vector)

$$\vec{b}_i = 2\pi \frac{\vec{a}_j \times \vec{a}_k}{\vec{a}_i \cdot \vec{a}_j \times \vec{a}_k}$$

$$\frac{1}{d_{hkl}^2} = \frac{1}{(1+2\cos\alpha\cos\beta\cos\gamma - \cos^2\alpha - \cos^2\beta - \cos^2\gamma)} \times \{\frac{h^2\sin^2\alpha}{a^2} + \frac{k^2\sin^2\beta}{b^2} + \frac{l^2\sin^2\gamma}{c^2} + \frac{2hk}{ab}(\cos\alpha\cos\beta - \cos\gamma) - \frac{2kl}{bc}(\cos\beta\cos\gamma - \cos\alpha) - \frac{2hk}{ab}(\cos\gamma\cos\alpha - \cos\beta)\}$$

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Space Groups

There are 7 crystal systems:

*Triclinic, all cases not satisfying the requirements of any other system. There is no necessary symmetry other than translational symmetry, although inversion is possible.

*Monoclinic, requires either 1 twofold axis of rotation or 1 mirror plane.

*Orthorhombic, requires either 3 twofold axes of rotation or 1 twofold axis of rotation and two mirror planes.

Tetragonal, requires 1 fourfold axis of rotation.

*Rhombohedral, also called trigonal, requires 1 threefold axis of rotation.

Hexagonal, requires 1 six fold axis of rotation.

*Isometric or cubic, requires 4 threefold axes of rotation.

Crystal system	No. of <u>point</u> groups	No. of <u>bravais</u> lattices	No. of <u>space</u> groups
Triclinic	2	1	2
<u>Monoclinic</u>	3	2	13
<u>Orthorhombic</u>	3	4	59
Tetragonal	7	2	68
Rhombohedral	5	1	25
Hexagonal	7	1	27
<u>Cubic</u>	5	3	36
Total	32	14	230

http://en.wikipedia.org/wiki/Crystal_system

Space Groups

CONTINUED

Origin at 0, y,0

Cmm2

International Tables for Crystallography (2006). Vol. A, Space group 35, pp. 238-239.



Origin on mm2

Asymmetric unit $0 \le x \le \frac{1}{4}; \quad 0 \le y \le \frac{1}{2}; \quad 0 \le z \le 1$

Symmetry operations

For $(0, 0, 0)$ + set			
(1) 1	(2) 2 0,0, <i>z</i>	(3) $m x, 0, z$	(4) $m = 0, y, z$
For $(\frac{1}{2}, \frac{1}{2}, 0)$ + set			
(1) $t(\frac{1}{2}, \frac{1}{2}, 0)$	(2) 2 $\frac{1}{4}, \frac{1}{4}, z$	(3) $a x, \frac{1}{4}, z$	(4) $b = \frac{1}{4}, y, z$

Generators selected (1); t(1,0,0); t(0,1,0); t(0,0,1); $t(\frac{1}{2},\frac{1}{2},0)$; (2); (3)

Po	sitie	ons					
Mu	ıltipli	icity,		Coordin	nates		Reflection conditions
Sit	e syn	nmetry		(0,0,0)+	$(\frac{1}{2}, \frac{1}{2}, 0)+$		General:
8	f	1	(1) <i>x</i> , <i>y</i> , <i>z</i>	(2) <i>x</i> , <i>y</i> , <i>z</i>	(3) <i>x</i> , <i>y</i> , <i>z</i>	(4) <i>x</i> , <i>y</i> , <i>z</i>	$\begin{array}{ll} hkl : h+k=2n\\ 0kl : k=2n\\ h0l : h=2n\\ hk0 : h+k=2n\\ h00 : h=2n\\ 0k0 : k=2n\\ \end{array}$
							Special: as above, plus
4	е	<i>m</i>	0, y, z	$0, \bar{y}, z$			no extra conditions
4	d	. <i>m</i> .	x,0,z	x,0,z			no extra conditions
4	С	2	$\frac{1}{4}, \frac{1}{4}, Z$	$\frac{1}{4}, \frac{3}{4}, z$			hkl : $h = 2n$
2	b	<i>m m</i> 2	$0, \frac{1}{2}, z$				no extra conditions
2	a	<i>m m</i> 2	0,0,z				no extra conditions
Sy	mm	etry of s	pecial proje	ctions			
Al	ong	[001] c2n	nm		Along [100] p11	n1	Along [010] p11m
a	= a	$\mathbf{b}' = \mathbf{I}$)	1	$\mathbf{a}' = \frac{1}{2}\mathbf{b}$ $\mathbf{b}' =$	c	$\mathbf{a}' = \mathbf{c}$ $\mathbf{b}' = \frac{1}{2}\mathbf{a}$

Alor

Along [001] c2mm	Along $[100] p 1 m 1$	
$\mathbf{a}' = \mathbf{a}$ $\mathbf{b}' = \mathbf{b}$	$\mathbf{a}' = \frac{1}{2}\mathbf{b}$ $\mathbf{b}' = \mathbf{c}$	
Origin at 0,0,z	Origin at $x, 0, 0$	

Maximal non-isomorphic subgroups

I	[2]C1m1(Cm, 8)	(1; 3)+
	[2]Cm11(Cm, 8)	(1; 4)+
	[2] C112 (P2, 3)	(1; 2)+
IIa	[2] Pba2(32)	1; 2; (3; 4) + $(\frac{1}{2}, \frac{1}{2}, 0)$
	[2] Pbm2 (Pma2, 28)	1; 3; $(2; 4) + (\frac{1}{2}, \frac{1}{2}, 0)$
	[2] Pma2 (28)	1; 4; (2; 3) + $(\frac{1}{2}, \frac{1}{2}, 0)$
	[2] Pmm2 (25)	1; 2; 3; 4

 $\textbf{IIb} \quad [2] Ima2(\mathbf{c}' = 2\mathbf{c})(46); [2] Ibm2(\mathbf{c}' = 2\mathbf{c})(Ima2, 46); [2] Iba2(\mathbf{c}' = 2\mathbf{c})(45); [2] Imm2(\mathbf{c}' = 2\mathbf{c})(44); [2] Cc2(\mathbf{c}' = 2\mathbf{c})(37); [2] Imm2(\mathbf{c}' = 2\mathbf{c})(44); [2] Cc2(\mathbf{c}' = 2\mathbf{c})(47); [2] Imm2(\mathbf{c}' = 2\mathbf{c})(47); [$ [2] Cmc2, (c' = 2c) (36); [2] Ccm2, (c' = 2c) (Cmc2, 36)

Maximal isomorphic subgroups of lowest index

IIc [2] Cmm2 (c' = 2c) (35); [3] Cmm2 (a' = 3a or b' = 3b) (35)

Minimal non-isomorphic supergroups

- I $[2] Cmmm (65); [2] Cmme (67); [2] P4mm (99); [2] P4bm (100); [2] P4_2 cm (101); [2] P4_2 nm (102); [2] P\bar{4}2m (111); \\ [2] P4_2 mm (102); [2] P\bar{4}2m (111); \\ [2] P4_2 mm (102); [2$ [2] P42, m (113); [3] P6mm (183)
- п [2] Fmm2(42); [2] $Pmm2(\mathbf{a}' = \frac{1}{2}\mathbf{a}, \mathbf{b}' = \frac{1}{2}\mathbf{b})$ (25)

Single Crystals:

Sample must be correctly oriented in space with respect to the chosen reflection plane.









What if you don't have a single crystal?







Powder Diffraction

*Powder

 Sizable samples have billions of crystals

In the absence of texture, all crystal orientations are equally represented



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Powder Instruments at user facilities



beamline 11BM at APS



Constant wavelength ($2dsin\Theta = \lambda$)



Time of flight instrument (POWGEN)







for the U.S. Department of Energy

Installation:





Time-of-flight ($2dsin\Theta = \lambda$)



Time of Flight method

de Broglies relationship:

 λ =h/mv=ht/mL

Combine with Bragg to get

 $2dsin\theta = ht/mL => t=2dsin\theta.mL/h$

 t_{hkl} =505.5569L d_{hkl} sin θ

However there is correction to this due to the moderator

t_{hkl}=DIFC*d_{hkl} +DIFA*d_{hkl}² +Zero (GSAS notation)

Resolution:

 $\mathsf{R}(\mathsf{d})=\Delta \mathsf{d}/\mathsf{d}=[(\Delta \mathsf{t}/\mathsf{t})^2+(\Delta \mathsf{L}/\mathsf{L})^2+(\Delta \theta)^2\mathsf{cot}^2\theta]^{\frac{1}{2}}$

Bragg Intensity:

 $Y_{ph} = F_{ph}^{2}H(T - T_{ph})K_{ph}$ where $K_{ph} = E_{ph}A_{h}O_{ph}M_{p}L/V_{p}$



Rietveld Refinement



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Hugo Rietveld



Dr. Rietveld at the neutron powder diffractometer at the High Flux Reactor of the Energy Reseach Foundation ECN in Petten, The Netherlands. (1987)

J. Appl. Cryst. 2, 65, 1969

"A structure refinement method is described which does not use integrated neutron powder intensities, single or overlapping, but employs directly the profile intensities obtained from step-scanning measurements of the powder diagram. Nuclear as well as magnetic structures can be refined, the latter only when their magnetic unit cell is equal to, or a multiple of, the nuclear cell. The least-squares refinement procedure allows, with a simple code, the introduction of linear or quadratic constraints between the parameters."





In a diffraction experiment if the sample is a powder, there will be many grains aligned to diffract the incident beam of neutrons/x-rays. 3D information is reduced to 1D, makes analysis harder than single crystal experiments.

Rietveld Refinement Least Square Method

Model that describes the structure

Profile parameters (lattice, line-shape, background etc.)

Atomic information (fractional co-ordinates, thermal parameters fractional occupancy etc.)

No effort is made in advance to allocate observed intensity to particular Bragg reflections nor to resolve overlapped reflections. Consequently, a reasonably good starting model is needed. The method is a structure refinement method and not a structure solution method.



Rietveld Refinement (cont'd)

The contribution of an atom at r_i in real space to a reflection K = (hkl) is given by the structure factor of that reflection

$$F_{hkl} = \sum_{j} N_{j} b_{j} e^{2\pi i K \cdot r_{j}} e^{-M_{j}}$$

(M_j = Debye-Waller factor, $M_j = 8\pi^2 \overline{u_s^2} \sin^2 \theta / \lambda^2$

- N_i = site occupancy
- **b**_j = scattering length)

Rietveld refinement models the entire pattern as calculate intensities:

$$y_{oi} = s \sum_{K} L_{K} |F_{K}|^{2} f(t_{i} - t_{K}) + y_{bi}$$

(s = scale factor, L_{k} = instrumental and sample factors, f = profile function, y_{ci} = background)



Rietveld Refinement (cont'd)

The Least Square refinement then adjusts the refinable parameters to minimize the residuals until the best fit is obtained.

$$\chi^{2} = \frac{\sum_{i=1}^{N_{obs}} \mathbf{w}_{i} (\mathbf{I}_{oi} - \mathbf{I}_{ci})^{2}}{(\mathbf{N}_{obs} - \mathbf{N}_{var})}$$

Here $w_i = 1/\sigma_i^2$, is the statistical weight of the *i* th profile observation which is the inverse of the variance of the *i* th observation. I_{oi} and I_{ci} are observed and calculated intensities.

From a purely mathematical point of view, R_{wp} is the most meaningful R factor because the numerator is the residual being minimized. So this is the best indicator of the progress of the refinement.

$$R_{wp}^{2} = \frac{\sum_{i=1}^{N_{obs}} \mathbf{w}_{i} (\mathbf{I}_{oi} - \mathbf{I}_{ci})^{2}}{\mathbf{w}_{i} (\mathbf{I}_{oi})^{2}}$$

While numerical criteria are important it is also imperative to use graphical criteria of fit like difference plots.



Peak Profiles:

CW peak shapes

Convolution of pseudo-Voigt with result of considering the intersection of the Debye Scherrer diffraction cone that is at the scattering angle of 2Θ and a finite height slit positioned below 2Θ by τ

H(Δ**T)**=**∫P(**Δ**T**-τ**)D**(τ)**d**τ

 $\sigma = [U \tan^2 \Theta + V \tan \Theta + W + P/\cos^2 \Theta]^{1/2}$ (Gaussian variance) $\gamma = (X + X_{e/s} \cos \phi) / \cos \Theta + (Y + Y_e \cos \phi + g_L d^2) \tan \Theta$ (Lorentzian, size broadening due to stacking fault)

TOF diffractometers that use cryogenic moderators have more complex behavior for a b and peak position.



Peak Profiles:

TOF peak shapes

Convolution of rising and falling (back to back) exponentials with pseudo-Voigt (a linear combination of Lorentzian and a Gaussian)

H(∆T)=∫E(∆T-†)P(†)d†



TOF diffractometers that use cryogenic moderators have α , β and peak position.

27 Ref: R,B. Von Dreele et. al., J. Appl. Cryst. 15, 581 (1982) for the U.S. Department of Energy



TOF Peak Profiles (powgen):

T=DIFC*d+DIFA*d²+ZERO

However the new formulation gives you how to calculate the relationship between time and d spacing which include epithermal and thermal parameters.

$$\begin{split} T_{\rm h} &= nT_{\rm h}^{\rm e} + (1-n)T_{\rm h}^{\rm t} \\ T_{\rm h}^{\rm e} &= Z_0^{\rm e} + D_1^{\rm e}d_{\rm h} \\ T_{\rm h}^{\rm t} &= Z_0^{\rm t} + D_1^{\rm t}d_{\rm h} - \frac{A^{\rm t}}{d_{\rm h}} \\ n &= \frac{1}{2} \operatorname{erfc}\{w_{\operatorname{cross}}(T_{\operatorname{cross}} - \frac{1}{d_{\rm h}})\} \end{split}$$

The exponentials also includes the epithermal and thermal component.

$$\frac{1}{\alpha} = n \alpha^{\mathsf{e}} + (1-n) \alpha^{\mathsf{t}} \qquad \frac{1}{\beta} = n \beta^{\mathsf{e}} + (1-n) \beta^{\mathsf{t}}$$
$$\alpha^{\mathsf{e}} = \alpha_0^{\mathsf{e}} + \alpha_1^{\mathsf{e}} d_{\mathsf{h}} \qquad \beta^{\mathsf{e}} = \beta_0^{\mathsf{e}} + \beta_1^{\mathsf{e}} d_{\mathsf{h}}$$
$$\alpha^{\mathsf{t}} = \alpha_0^{\mathsf{t}} - \frac{\alpha_1^{\mathsf{t}}}{d_{\mathsf{h}}} \qquad \beta^{\mathsf{t}} = \beta_0^{\mathsf{t}} - \frac{\beta_1^{\mathsf{t}}}{d_{\mathsf{h}}}$$

The rest is the standard back to back exponential that one uses for TOF function

We saw before peak shape is a convolution of a pseudo-Voigt function with a pair of back-to-back exponentials. So if t is the origin of time at the Bragg position the peak shape is given by

$$\Omega(x) = pV(x) \otimes E(x) = \int_{-\infty}^{+\infty} pV(x-t)E(t)dt$$
where
$$\begin{bmatrix} E(t) = 2Ne^{\alpha t} & t \le 0\\ E(t) = 2Ne^{-\beta t} & t > 0\\ N = \frac{\alpha\beta}{2(\alpha+\beta)} \end{bmatrix}$$



Information obtained from Rietveld Refinement:

Phase Fractions

Scale factors relate the weight fractions of p_{th} phase :

$$W_p = \frac{S_{ph}m_p}{\sum_{p=1}^{N_p} S_{ph}m_p}$$

(m_p = unit cell mass for phase p, S_{ph} = Rietveld scale factor)

Sample Broadening

Only affects the Gaussian component of the peak width; contributions from strain S and particle size broadening P can be separated:

S =
$$(1/C)[8\ln 2(\sigma_1^2 - \sigma_{1i}^2)]^{1/2}100\%$$

 $(\sigma_{1i} = \text{strain-free value for } \sigma_1)$

$$P = (CK) / [8 \ln 2\sigma_2]^{1/2} Å$$

(K = Scherrer constant)



Other things to be keep in mind

Recall $K_{ph} = E_{ph}A_hO_{ph}M_pL/V_p$

- **E**_{ph}: Extinction correction
- A_h: Absorption correction
- O_{ph}: Preferred orientation correction
- **M**_p: Reflection multiplicity
- L: Angle dependent correction (Lorentz-polarization)
- V_p : Unit cell volume for the phase



Pair Distribution Function from total scattering experiments

How can we get short range structural information?



Total Scattering Based Atomic Pair Distribution Function (PDF)



Applications of Powder Diffraction





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Phase ID and Quantitative analysis
 Structure and transport
 Neutron Powder Diffraction
 Time resolved in-situ studies
 Ab-initio structure solution
 Proteins Crystallography and Powder Diffraction



Phase ID: "Finger Printing" Hug et.al. Appl. Phys. A 83, 253 (2006)



Natural antique colorants include red pigments such as cinnabar and ochre and pink pigments such as madder. These archaeological pigments have been used as ritual and cosmetic make-up and they are a material proof of handcraft activities and trade in the Mediterranean.

The pigments were discovered during different excavations in archaeological sites of Tunisia (Carthage, Kerkouane, Bekalta, Bouaarada and elsewhere).



Sample : FCC5 Cinnabar and Quartz







Conclusions

Ten punic make-up samples were studied with SR-XRD using a 2D CCD detector and high angular resolution powder diffraction. Four samples (B1, B2, B3 and FCC5) contain quartz and cinnabar while four other samples (B10, FCC4, FCC6 and OCRB) contain quartz and hematite. The presence of quartz is probably due to sand/clay from the excavation area.

These results are similar to what would be obtained from raw materials indicating that these eight samples were not subject to any preparation by the Carthaginians. These eight samples were used as ritual make-up. However, the last two samples (FCC2 and C41C) showed an amorphous background, their preparation required sophisticated techniques corresponding to cosmetic make-up; they contain purpurin as major pigment which is formulated in a similar fashion as a lacquer.

Resources (databases)

• Powder diffraction file, maintained by ICDD: Release 2008 of the Powder Diffraction File contains 622,117 unique material data sets. Each data set contains diffraction, crystallographic and bibliographic data, as well as experimental, instrument and sampling conditions and select physical

properties in a common standardized format. <u>http://www.icdd.com/products/overview.htm</u>

- * CCDC (Chembridge Crystallographic database): organic structures
- * ICSD (Inorganic crystal structure database): FIZ
- * NIST & MPDS



Why Neutrons ?

- Electrically neutral; penetrates centimeters of bulk material (allows non-destructive bulk analysis)
- Detects light atoms even in the presence of heavy atoms (organic crystallography) - H is special!
- Distinguishes atoms adjacent in Periodic table and even isotopes of the same element (changing scattering picture without changing chemistry)
- Magnetic moment (magnetic structure)
- Ease of *in-situ* experiments, e.g. variable temperature, pressure, magnetic field, chemical reaction etc.



Ba₂CuWO₆: An Ordered Tetragonal Perovskite



Simple cubic AMX₃ perovskite: a = 3.8045.

Double Perovskites $A_2MM'O_6$: Out of 3 possible ordering only 2 observe



Model #1: Ordered alternation of MO_6 and $M'O_6$ octahedra in one direction, leading to formation of layered perovskite.



Model #2: Ordered alternation in the three directions of space, resulting in rock-salt ordered superstructure.



<u>Space</u> Group	P4/mmm					
Lattice	a = 3.94 Å; c = 8.64 Å					
Atom	<u>x</u>	y	<u>z</u>	Occupancy		
Ba	1⁄4	1⁄4	1/2	1		
Cu	0	0	0	1		
W	0	0	0	1		
O (1)	0	0	1⁄4	1		
O(2)	1/2	0	0	1		
O (3)	1/2	0	1/2	1		



<u>Space</u> <u>Group</u>	I4/m			
Lattice	a = 5.57 Å; c = 8.64 Å			
<u>Atom</u>	<u>x</u>	<u>y</u>	<u>z.</u>	Occupancy
Ba	0	1/2	1⁄4	1
Cu	0	0	0	1
W	0	0	0	1
O(1)	0	0	0.25	1
O(2)	0.25	0.25	0	1











Recall Cu^{2+} electronic configuration $(t_{2g})^6(e_g)^3$: <u>Jahn</u> <u>Teller Distortion?</u>

So in fact CuO_6 octahedra are elongated along the c axis. The e_g orbital is split into

$$(d_{x^2-y^2} \text{ and } d_{z^2}^2)$$

Iwanaga et. al. J. Solid State. Chem. 147, 291(1999)



Magnetism & powder diffraction





Introduction to Magnetism

- Origin of magnetism electrons.
 - Electrons have a magnetic moment (dipole; μ_S). <u>Magnetic moments</u> arise from two properties of an electron:
 - 1. Motion around the nucleus (gyromagnetic ratio)
 - 2. Total spin quantum number (S = Σ s; s = $\pm \frac{1}{2}$)



• Dipole unit – Bohr magnetons (μ_B). 1 μ_B = 9.2742×10⁻²⁴ J/T





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Reinvestigation of the Magnetocaloric effect (MCE) in Mn_5Si_3



Time resolved Powder Diffraction: Hydrogen Storage Materials for mobile application





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Li₃N : Hydrogen Storage Candidate.

Chen et. al: (Nature Nov 2002)

Li Imide Li Amide Li₃N + 2H₂ \longleftrightarrow Li₂NH + LiH + H₂ \longleftrightarrow LiNH₂ + 2LiH



H₂ Absorption 9.3 wt% gain at 255°C H₂ Desorption 6.3 wt% at 200°C + 3wt % above 320°C Later (2004-2005) Meisner et. al. & others: 1. Li₃N + 2H₂ → Li₂NH + LiH + H₂ 2. Li₂NH + LiH + H₂ → LiNH₂ + 2LiH (~5.2% cyclable H₂)

Our Goal: To study this reaction in-situ in bulk material.



Neutron in-situ measurement (IPNS)

30.5h dedeuteride, 22.5h deuteride, 19h dedeuteride : cubic phase has changing lattice parameter (implying varying stoichiometry) while tetragonal phase has same (line phase)

Hug et. al., J Phys Chem C,111,10712,2007





Imide – Amide : Structural relationship (Ex-situ synchrotron experiment)

David et. al., JACS 129,1594,2006





Ab-initio Structure Solution from Powder Diffraction



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Structure solution from powder data:

Given atom positions, it is straightforward to compute the diffraction pattern

$$I_{hkl} = \left| \sum_{\text{atoms } j} f_j \exp(i\vec{Q}_{hkl} \cdot \vec{R}_j) \right|^2$$

Solve a new structure from powder data

- 1. Get data
- 2. Find the lattice
- 3. Space group (internal symmetries) systematic absences, density, guess, luck
- 4. Extract intensities of each individual (*hkl*) peak
- 5. Solve structure
- 6. Refine













Proteins and Powder Diffraction





Extreme limit: Proteins Work done by R. Von Dreele (Los Alamos) & P.W. Stephens It is possible to get usable data, and to refine it with sufficient chemical restraints. T3r3 Zn insulin hard grind fresh RT 1.5mm cap 0.700233





Structure solved from powder data & Rietveld refinement

Human Insulin Z	n complex
Native	Ground
a=80.96Å c=37.59Å Nrefined = 1754 Nrestraints=3871 Nreflections=9871 Resolution 3.06Å Rwp=3.34%	81.28Å 73.04Å 2925 7934 12734 3.22Å 3.77%

R.B. Von Dreele, P.W. Stephens, G.D. Smith, and R.H. Blessing, "The First Protein Crystal Structure Determined from X-ray Powder Diffraction Data: a Variant of T₃R₃ Human Insulin Zinc Complex Produced by Grinding," Acta Crystallographica D 56, 1549-53 (2000).





Current work at APS: Structure solution via molecular replacement





Take home message

Powder diffraction is an extremely powerful technique to study structural properties of a very wide variety of materials. To understand physical and chemical properties of materials it is crucial that we know how the "atoms are put together" and if you cannot grow those big single crystals....you can still learn quite a lot about your system using powder diffraction.



Reference material

- **Elements of X-ray diffraction (B.D. Cullity)**
- □Introduction to X-ray Powder Diffractometry (R. Jenkins & R.L. Snyder)
- Modern Powder Diffraction (edited by Bish & Post)
- The Rietveld Method (edited by R.A. Young)
- □Neutron Diffraction (G.E. Bacon)
- Theory of neutron scattering from condensed matter (S.W. Lovesey)
- Structure determination from powder diffraction data (Edited by W.I.F. David, K. Shankland, L.B. McCusker and Ch. Baerlocher)



Software and other resources: http://www.ccp14.ac.uk/

Indexing:

Crysfire: <u>http://www.ccp14.ac.uk/tutorial/crys/</u>

Rietveld:

- GSAS: <u>https://subversion.xor.aps.anl.gov/trac/EXPGUI/wiki</u>
- Fullprof: <u>http://www.ill.eu/sites/fullprof/</u>
- Rietan, Topas, Expo, JANA, Jade etc.

Structure Solution:

- DASH: <u>http://www.ccdc.cam.ac.uk/products/powder_diffraction/dash/</u>
- FOX: <u>http://vincefn.net/Fox/</u>
- Topas: <u>http://www.dur.ac.uk/john.evans/topas_academic/topas_main.htm</u>

